Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination
09/943,018	CHEN ET AL.
Examiner	Art Unit
Yogesh K. Aggarwal	2622

SEARCHED				
Class	Subclass	Date	Examiner	

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC)
	DATE	EXMR
348/231.1,231.3,231.7,231.9	5/11/2007	YKA
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